UTT170N08H

Preliminary

POWER MOSFET

170A, 80V N-CHANNEL ENHANCEMENT MODE TRENCH POWER MOSFET

DESCRIPTION

The UTC **UTT170N08H** is a N-channel Power MOSFET, it uses UTC's advanced technology to provide the customers with high switching speed and low gate charge, etc.

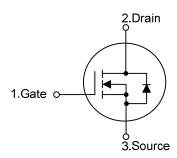
The UTC **UTT170N08H** applies to primary side switch, synchronous rectifier, Motor Drives, etc.

TO-220

■ FEATURES

- * $R_{DS(ON)}$ < 5.1 m Ω @ V_{GS} =10V, I_{D} =60A
- * High Cell Density Trench Technology
- * High Power and Current Handling Capability

■ SYMBOL



■ ORDERING INFORMATION

Ordering Number		Doolsons	Pin	Assignm	Dooking		
Lead Free	Halogen Free	Package	1	2	3	Packing	
UTT170N08HL-TA3-T	UTT170N08HG-TA3-T	TO-220	G	D	S	Tube	

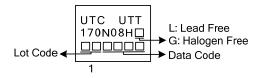
Note: Pin Assignment: G: Gate D: Drain S: Source

UTT170N08HG-TA3-T (1)Packing Type (1) T: Tube

(2)Package Type (2) TA3: TO-220

(3)Green Package (3) G: Halogen Free and Lead Free, L: Lead Free

MARKING



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■ **ABSOLUTE MAXIMUM RATINGS** (T_C=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		$V_{ extsf{DSS}}$	80	>	
Gate-Source Voltage		V_{GSS}	±20	V	
Continuous Drain Current	Continuous	I_{D}	170	Α	
Pulsed Drain Current	ulsed Drain Current Pulsed (Note 2)		680	Α	
Avalanche Current (Note 3)		I_{AR}	42	Α	
Avalanche energy	Single Pulsed (Note 3)	E _{AS}	88	mJ	
Peak Diode Recovery dv/dt (Note 4)		dv/dt	4.2	V/nS	
Power Dissipation		P_{D}	300	W	
Junction Temperature		T_J	+150	°C	
Storage Temperature Range		T _{STG}	-55 ~ +150	°C	

- Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

 Absolute maximum ratings are stress ratings only and functional device operation is not implied.
 - 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
 - 3. L=0.1mH, I_{AS} =42A, V_{DD} =50V, R_{G} =25 Ω , Starting T_{J} = 25 $^{\circ}$ C.
 - 4. $I_{SD} \le 30A$, di/dt $\le 200A/\mu s$, $V_{DD} \le V_{(BR)DSS}$, $T_J = 25$ °C.

■ THERMAL CHARACTERISTICS

PARAMETER	SYMBOL	RATINGS	UNIT	
Junction to Ambient	θ_{JA}	62.5	°C/W	
Junction to Case	θ _{JC}	0.42	°C/W	

■ ELECTRICAL CHARACTERISTICS (T_J =25°C, unless otherwise specified)

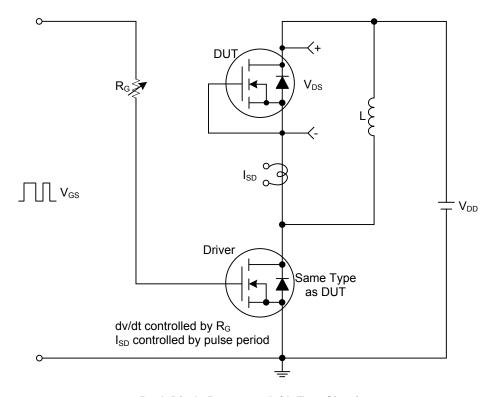
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		BV _{DSS}	I _D =250μA, V _{GS} =0V	80			V
Drain-Source Leakage Current		I _{DSS}	V _{DS} =80V, V _{GS} =0V			1	μΑ
Gate-Source Leakage Current	Forward		V _{GS} =+20V, V _{DS} =0V			+100	nA
	Reverse	I_{GSS}	V _{GS} =-20V, V _{DS} =0V			-100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}$, $I_D=250\mu A$	2.0		4.0	V
Static Drain-Source On-State Resistance		R _{DS(ON)}	V _{GS} =10V, I _D =60A			5.1	mΩ
DYNAMIC PARAMETERS							
Input Capacitance		C _{ISS}			4360		pF
Output Capacitance		Coss	V_{GS} =0V, V_{DS} =25V, f=1.0MHz		595		pF
Reverse Transfer Capacitance		C_{RSS}			260		pF
SWITCHING PARAMETERS							
Total Gate Charge (Note 1)		Q_G	V _{DS} =50V, V _{GS} =10V, I _D =1.3A,		260		nC
Gate to Source Charge		Q_GS	$I_D=100\mu A$ (Note 1, 2)		30		nC
Gate to Drain Charge		Q_GD	10-100μA (Note 1, 2)		45		nC
Turn-on Delay Time (Note 1)		t _{D(ON)}			190		ns
Rise Time		t_R	V_{DS} =30V, V_{GS} =10V, I_{D} =0.5A,		220		ns
Turn-off Delay Time		t _{D(OFF)}	R _G =25Ω (Note 1, 2)		650		ns
Fall-Time		t⊧			340		ns
SOURCE- DRAIN DIODE RATING	S AND CH	ARACTERIS'	TICS				
Maximum Body-Diode Continuous Current		Is				170	Α
Maximum Body-Diode Pulsed Current		I _{SM}				680	Α
Drain-Source Diode Forward Voltage (Note 1)		V_{SD}	I _S =40A, V _{GS} =0V			1.0	V
Reverse Recovery Time (Note 1)		t _{rr}	I _S =30A, V _{GS} =0V,		45		nS
Reverse Recovery Charge		Q _{rr}	dI _F /dt=100A/μs		53		nC

Notes: 1. Pulse Test: Pulse width ≤ 300µs, Duty cycle≤2%.

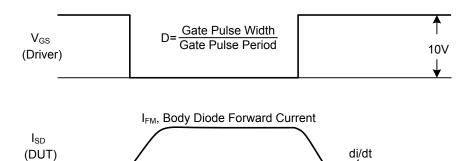
2. Essentially independent of operating temperature.



■ TEST CIRCUITS AND WAVEFORMS

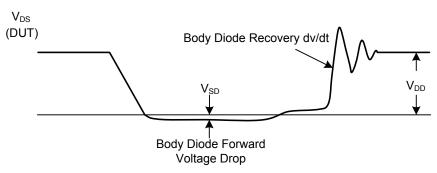


Peak Diode Recovery dv/dt Test Circuit



Body Diode Reverse Current

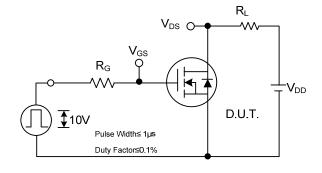
 I_{RM}

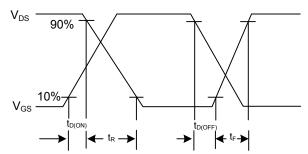


Peak Diode Recovery dv/dt Test Circuit and Waveforms

Peak Diode Recovery dv/dt Waveforms

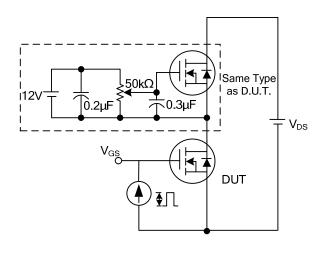
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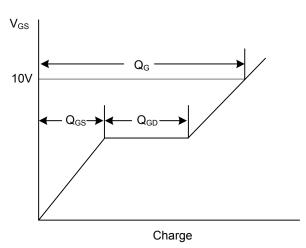




Switching Test Circuit

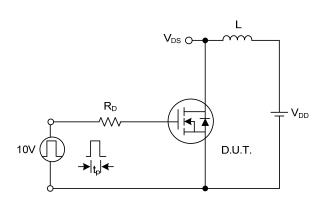
Switching Waveforms

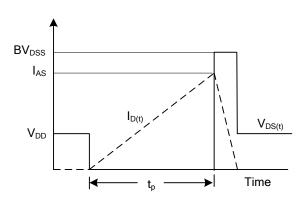




Gate Charge Test Circuit

Gate Charge Waveform





Unclamped Inductive Switching Test Circuit

Unclamped Inductive Switching Waveforms

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